## Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

MIURA ET AL.

Examiner

Art Unit

Wang, Claire

2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	236, 239, 232	1/29/2007	CW		
375	240.05, 240.07	1/29/2007	CW		

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor Name Search	1/21/2007	CW		
Consulted with Wenpeng Chen (PE)	1/25/2007	CW		
Attached EAST Search	1/29/2007	CW		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		